

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09940035	LEE ET AL.
Examiner	Art Unit	
MINH DINH	2132	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
713/165, 167-171, 185; 726/26-27, 29-30; 705/51, 57-58; 380/201-202, 278-279, 281-285 (text search only for all - see search history printout)	3/15/08	MD
EAST (US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB) - see search history printout	3/15/08	MD
NPL (IEEE, GOOGLE)	3/15/08	MD
Inventor Name Search	3/16/08	MD

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner